Application/Control No. Applicant(s)/Patent Under Reexamination 10/698,659 LEISTRA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Elena Tsoy 1762 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-5,981,097 11-1999 Rajendran, Govindarajulu 429/33 Α US-В US-С US-D US-Е US-F US-G US-Н US-US-US-Κ US-L US-Μ **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY JP 07024315 A 01-1995 Ν Japan NAKAGAWA et al. 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W Х

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